

Search Notes



Application/Control No.

10/633,243

Examiner

Alan S. Chen

Applicant(s)/Patent under Reexamination

BABKA ET AL.

Art Unit

2182

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|----------|----------|
| 710 | 15-19 | 8/4/2006 | ASC |
| | 52-57 | | |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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| see search history printouts | | 4/17/07 | ASC |

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

| | DATE | EXMR |
|---|----------|------|
| (EAST) USPAT; USPGPUB; EPO; JPO; IBM_TDB; DERWENT PLUS; Inventor Search; limited class search | 8/4/2006 | ASC |
| 101 Help Panel | 8/4/2006 | ASC |
| 101 Help Panel conditional statements | 12/22/06 | ASC |
| update EAST 715/200-866; 710/15-19 | 12/22/06 | ASC |
| updated EAST limited class search | 4/17/07 | ASC |
| Tanh Nguyen (AU2182) Richard Ellis (AU2183) Kim Huynh (AU2182) | 4/17/07 | ASC |
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